

## Examples of different X-ray diffraction optical configurations to Clay Minerals analysis

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**LIVING  
CLAYS** From nano-scale  
interactions to  
incorporation  
in everyday life

## Aim

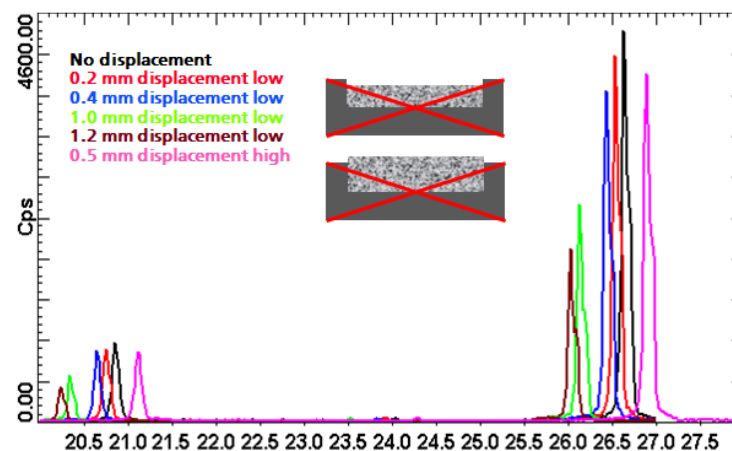
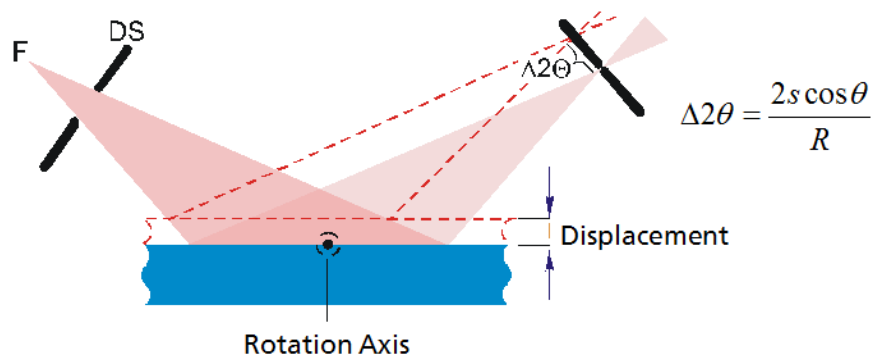
- The aim of this work is to present results of data collection of clay minerals by XRD obtained using different configurations

## Materials vs Configuration

- Different configuration are suggested by different materials; examples:
  - Mesoporous silica – peaks at around  $1^\circ 2\theta$
  - Pharmaceutical –  $1-40^\circ 2\theta$
  - Rock forming minerals –  $3-75^\circ 2\theta$
  - Clays – mainly  $3-75^\circ 2\theta$
  - Metals – from  $15^\circ-130^\circ 2\theta$
- Sample preparation is important to obtain a good data quality

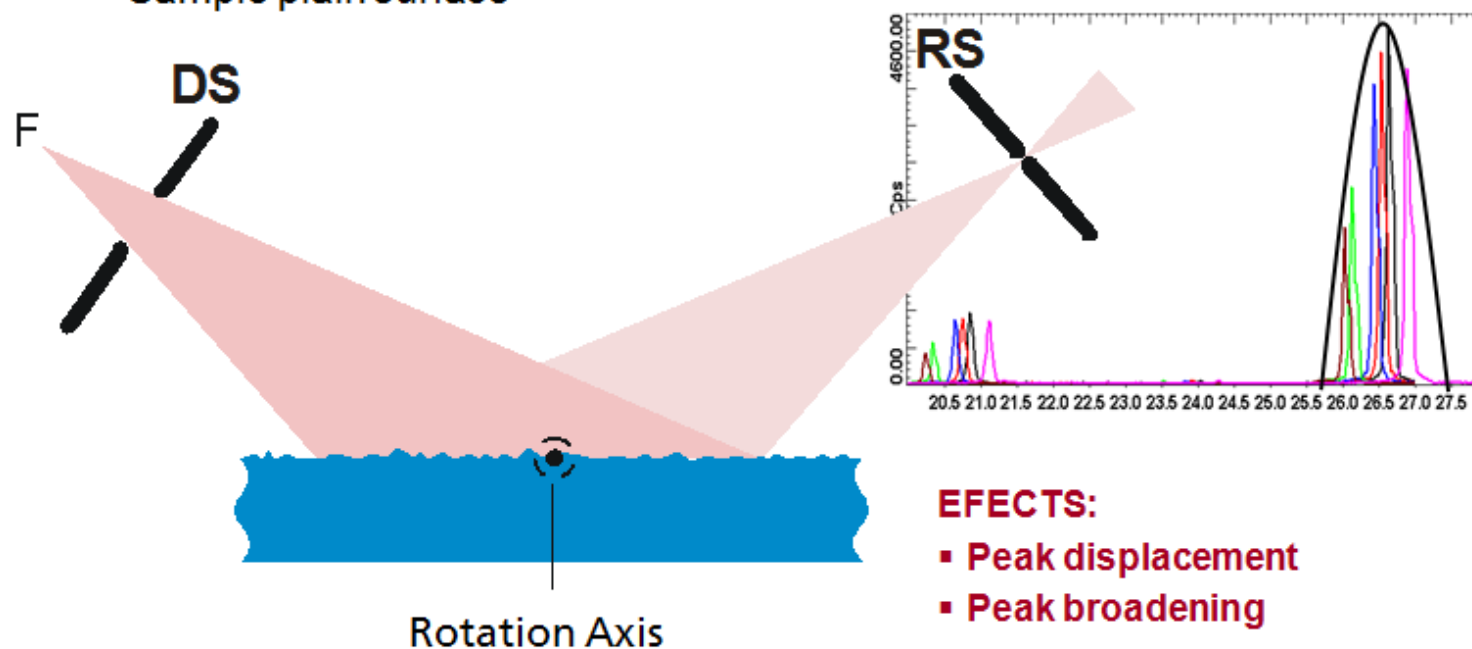
# Sample preparation – (1) Sample height

## Sample height

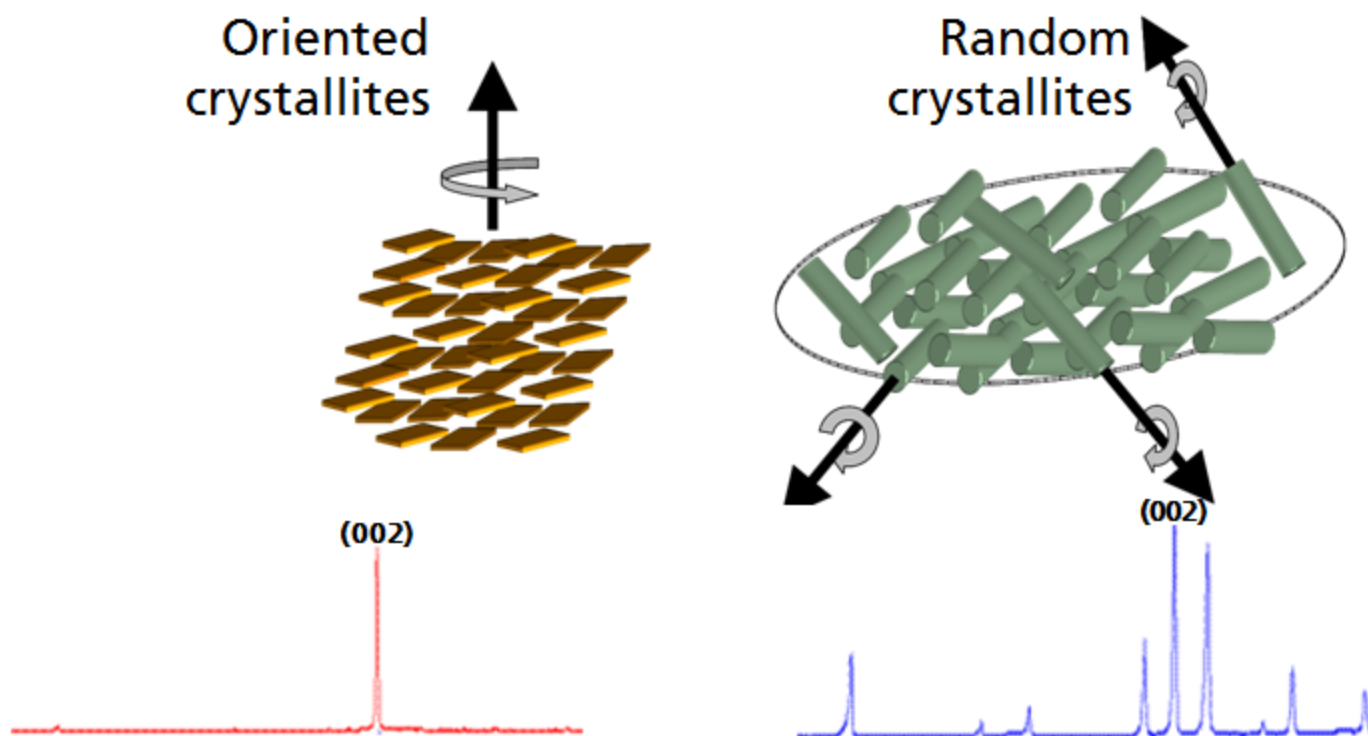


## Sample preparation – (2) Flat surface

- Sample plain surface



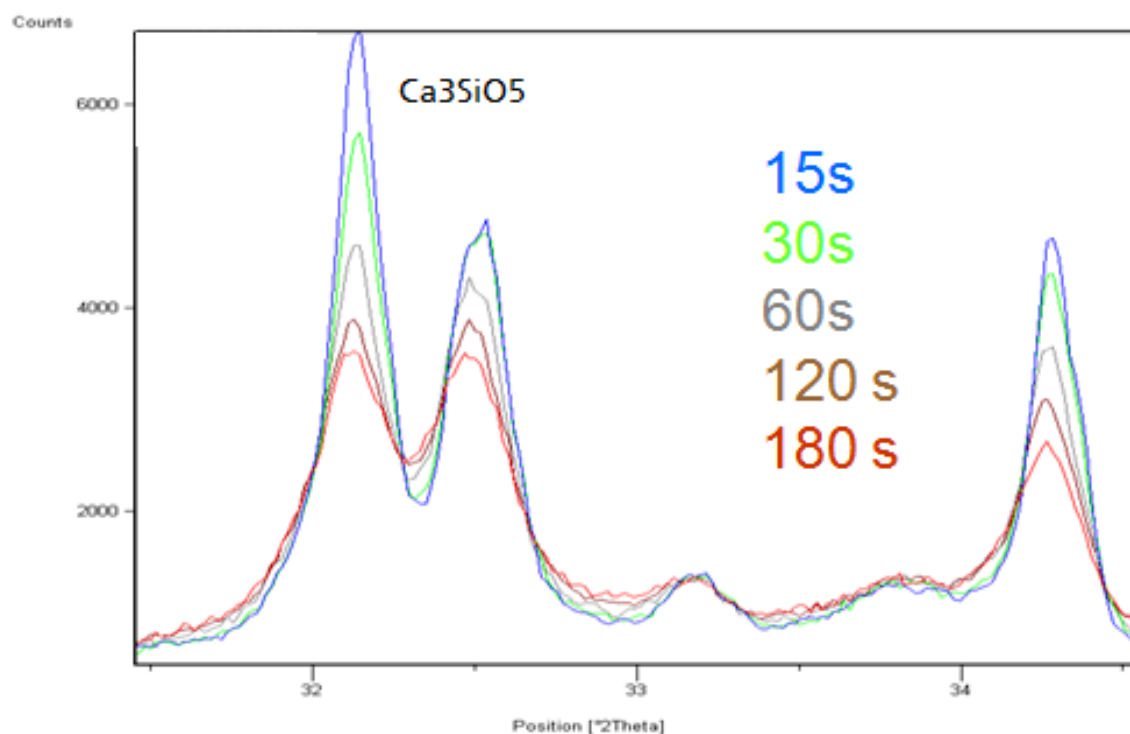
## Sample preparation – (3) Preferred orientation



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## Sample preparation – (4) Grain size

Differences in peak profiles of same sample after different time of milling



## Configurations

- (1) use of fixed divergent slit settings ( $1^\circ$ ;  $\frac{1}{2}^\circ$ ;  $\frac{1}{4}^\circ$ ;  $\frac{1}{8}^\circ$ ;  $\frac{1}{16}^\circ$ ;  $\frac{1}{32}^\circ$ )
- (2) beam knife
- (3) Soller slits – 0.02 and 0.04 radians
- (4) Active length (detector)
- (5) goniometer radius of 240 and 145mm radius in a benchtop
- (6) capillary and transmission mode



## Sample preparation

- Samples enriched in Illite, Sepiolite, Nacrite, Montmorillonite, Attapulgite, Kaolinite, Beidellite, Halloysite and Dickite were used

# Sample preparation

- Samples were all prepared in a backloading kit



- Or in a capillary



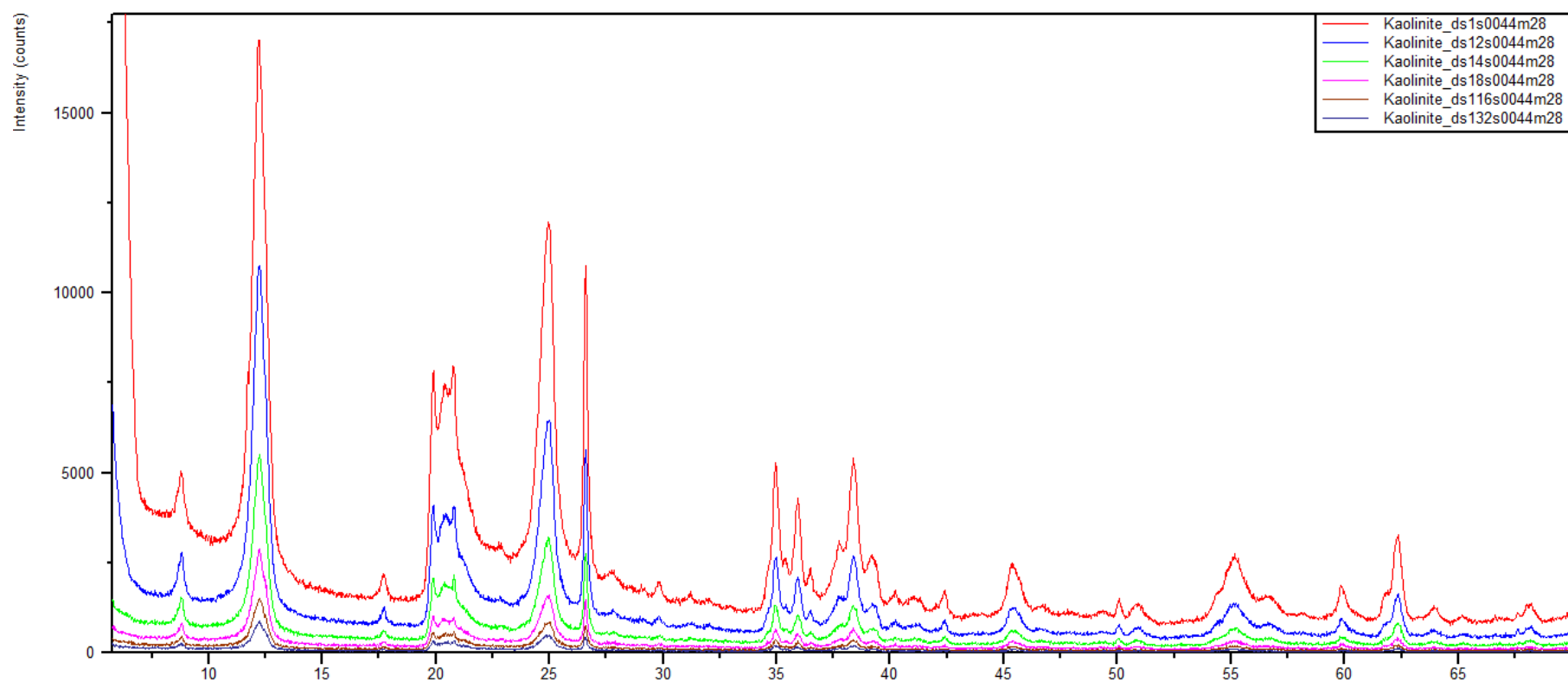
## (1) Different divergent slit sizes

- Fixed divergent slits  $\Rightarrow 1^\circ; \frac{1}{2}^\circ; \frac{1}{4}^\circ; \frac{1}{8}^\circ; \frac{1}{16}^\circ; \frac{1}{32}^\circ$
- Soller slit  $\Rightarrow 0.04$  rad
- Beam knife
- Total time  $\Rightarrow 4'28''$

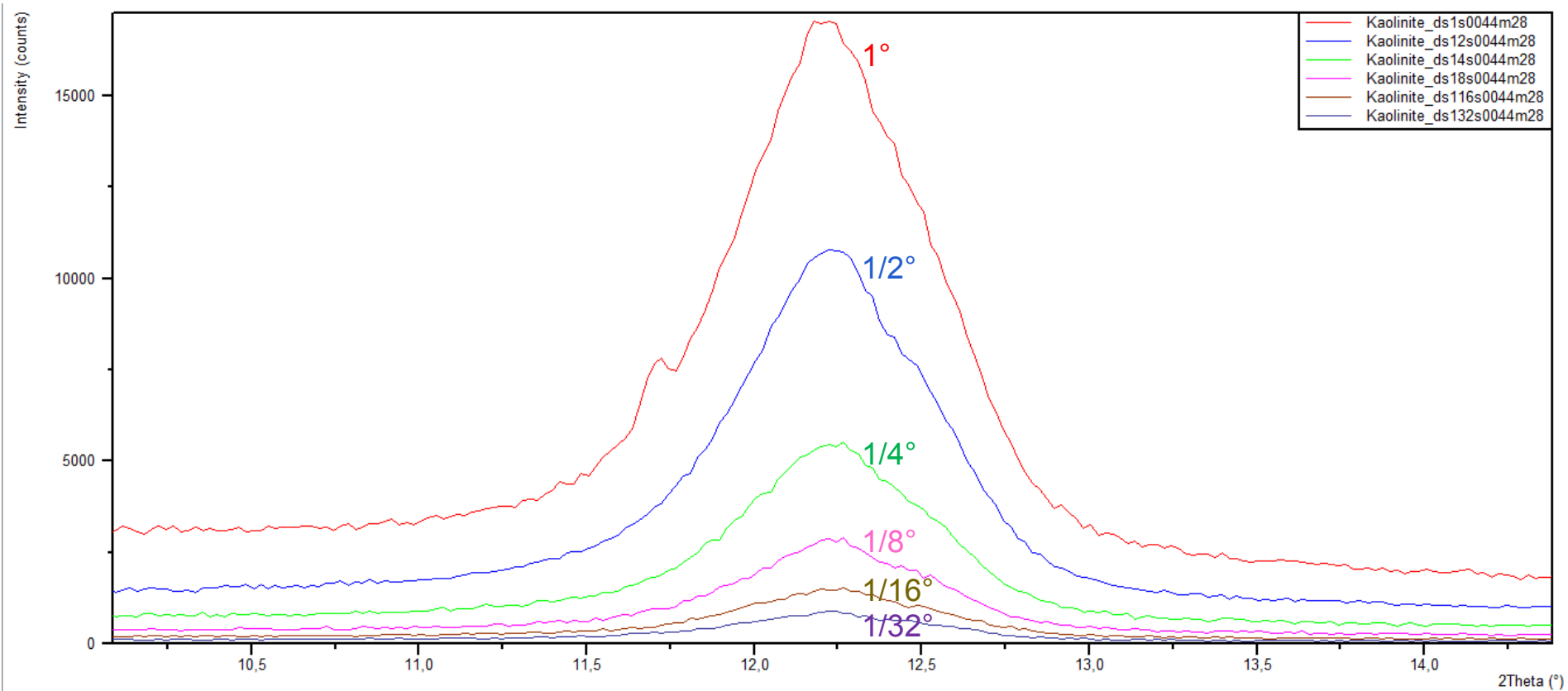


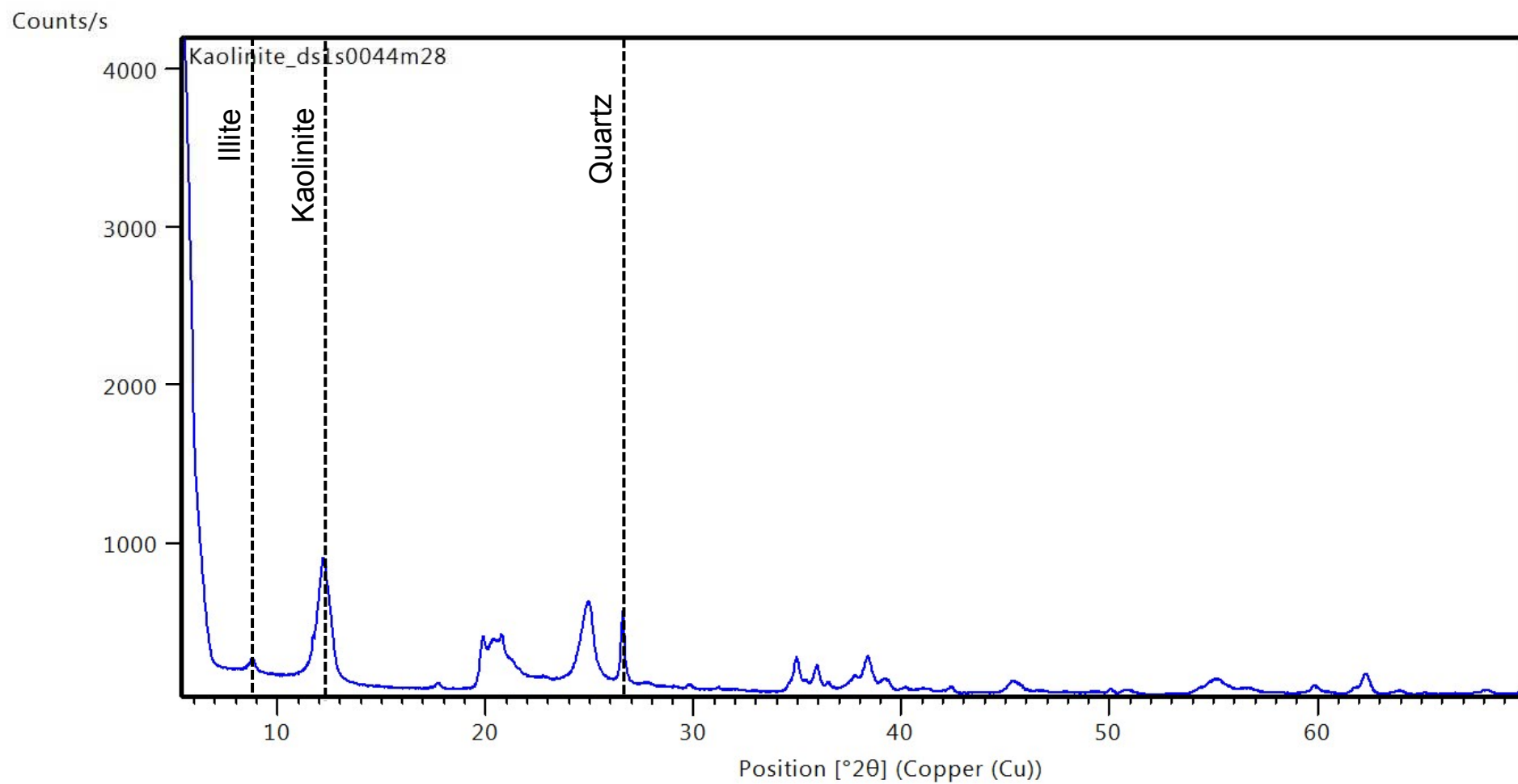
$1^\circ$  and  $\frac{1}{2}^\circ \Rightarrow$  high direct beam effect  $\Rightarrow$  INTENSITY

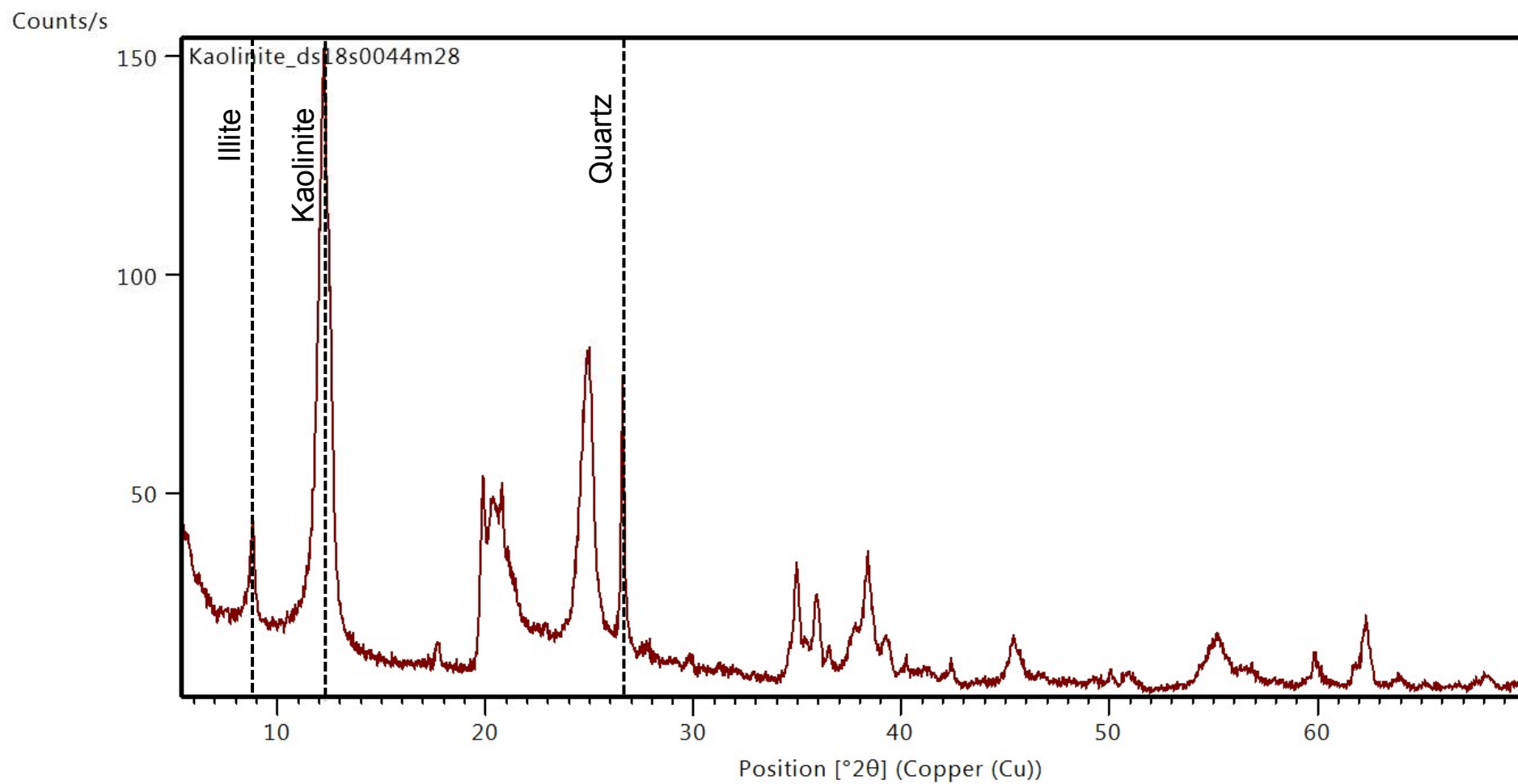
$\frac{1}{32}^\circ$  and  $\frac{1}{16}^\circ \Rightarrow$  much lower intensities  $\Rightarrow$  RESOLUTION



- By using a bigger divergence slit opening, the irradiated area is increased as well as the number of grain orientations that can participate to the diffracted signal.
- However, below  $20^\circ$ , the  $1^\circ$  divergence slit irradiate a larger area, more than the sample size, leading to an increase of the background intensity.
- As a consequence, the gain factor in intensity at low angle is reduced compared to the one at higher angle.

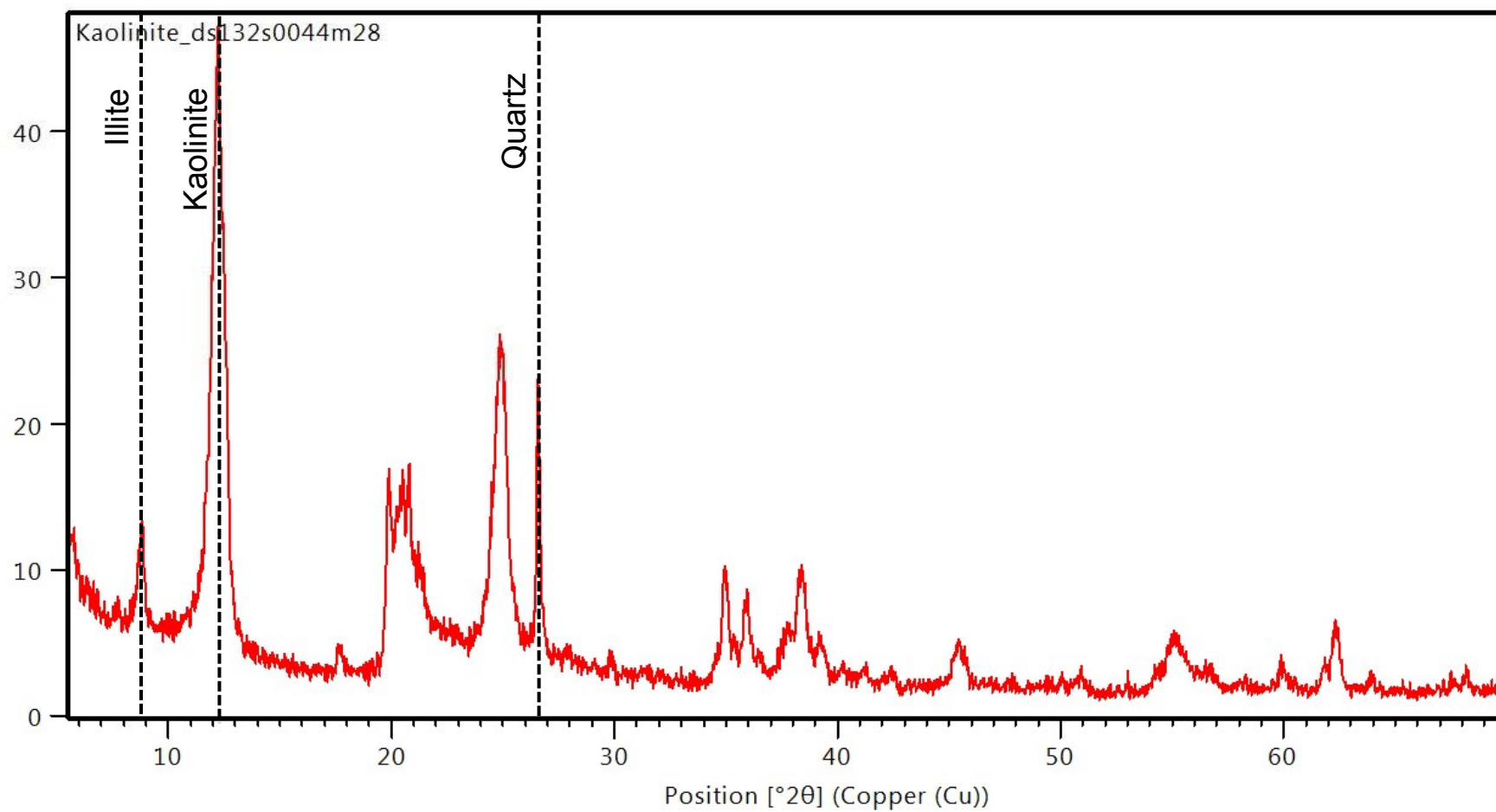




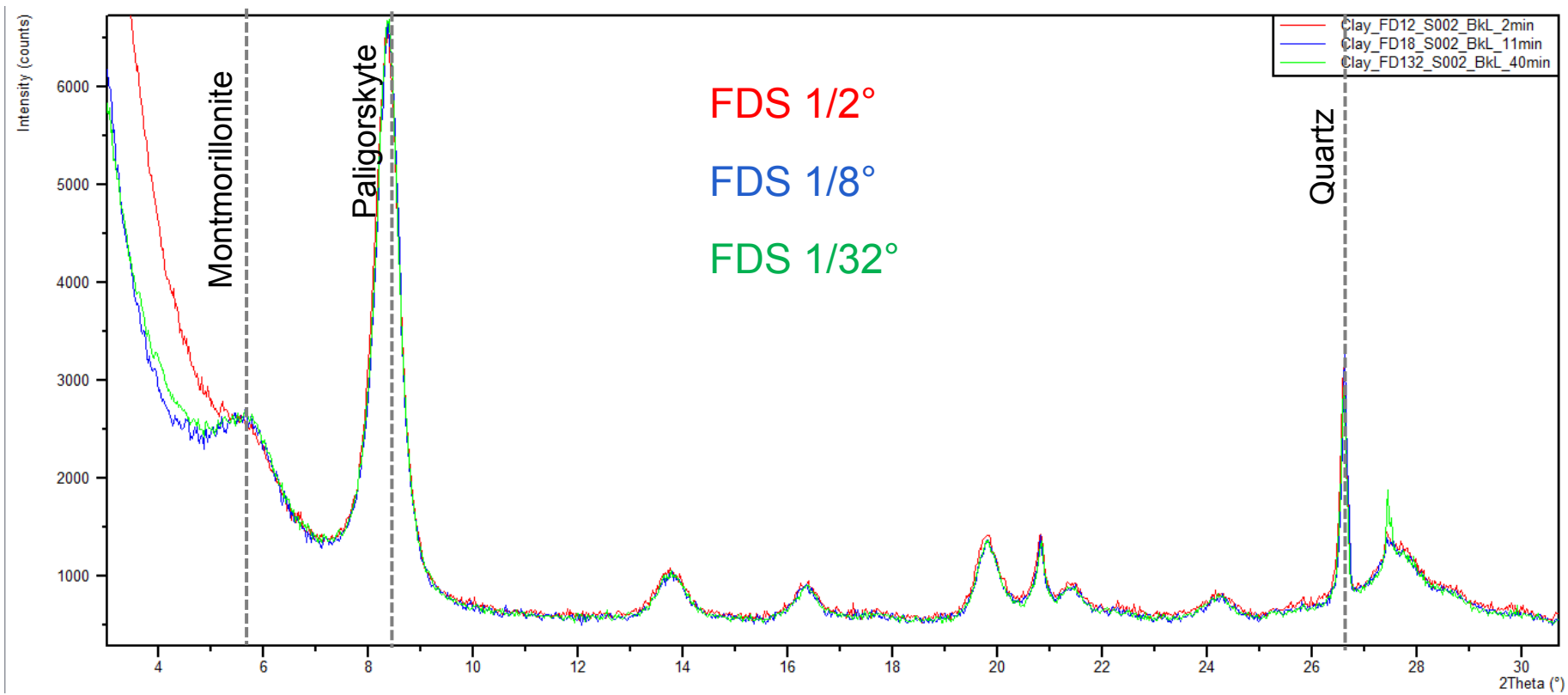


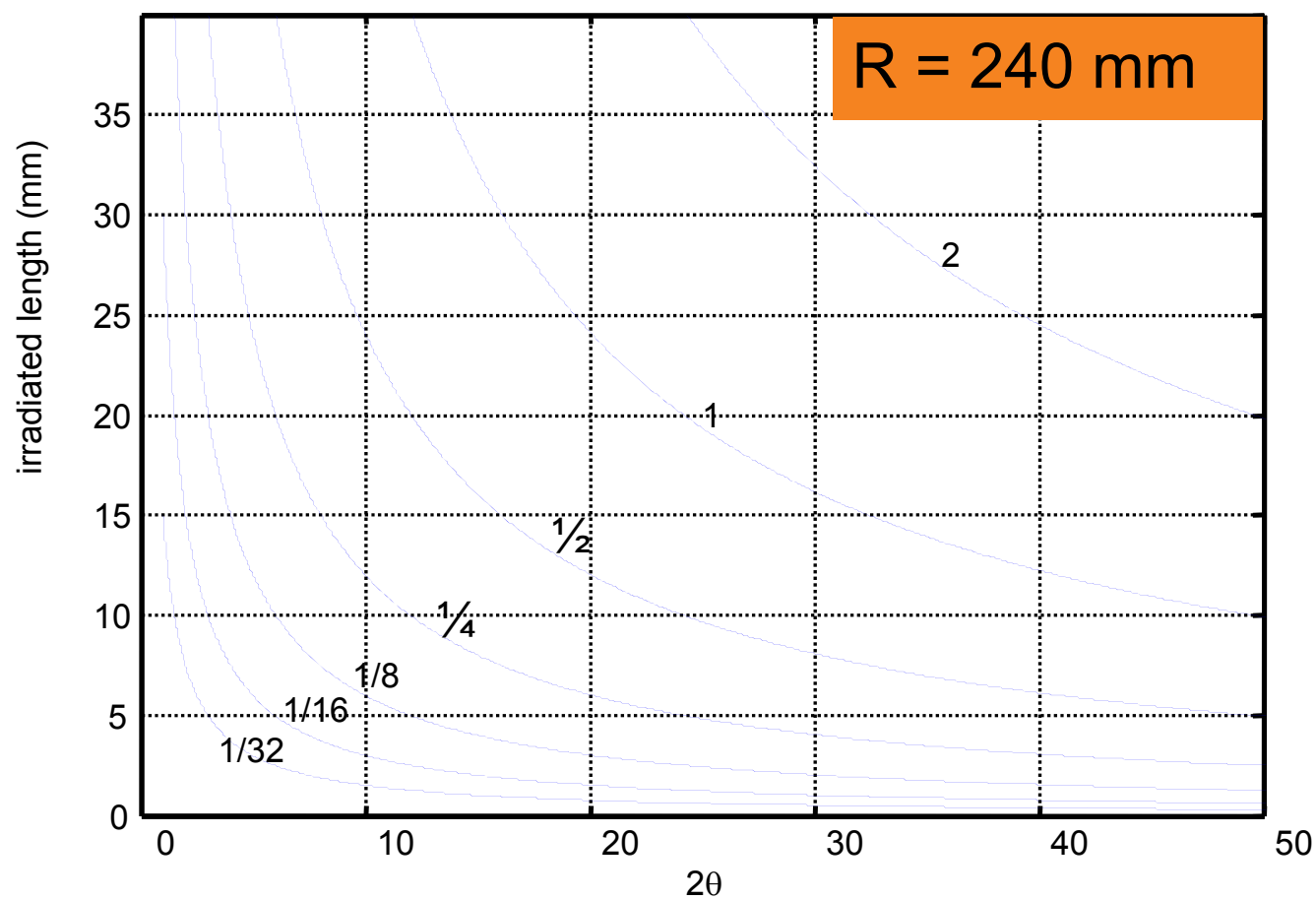


Counts/s



Goniometer radius => 145 mm





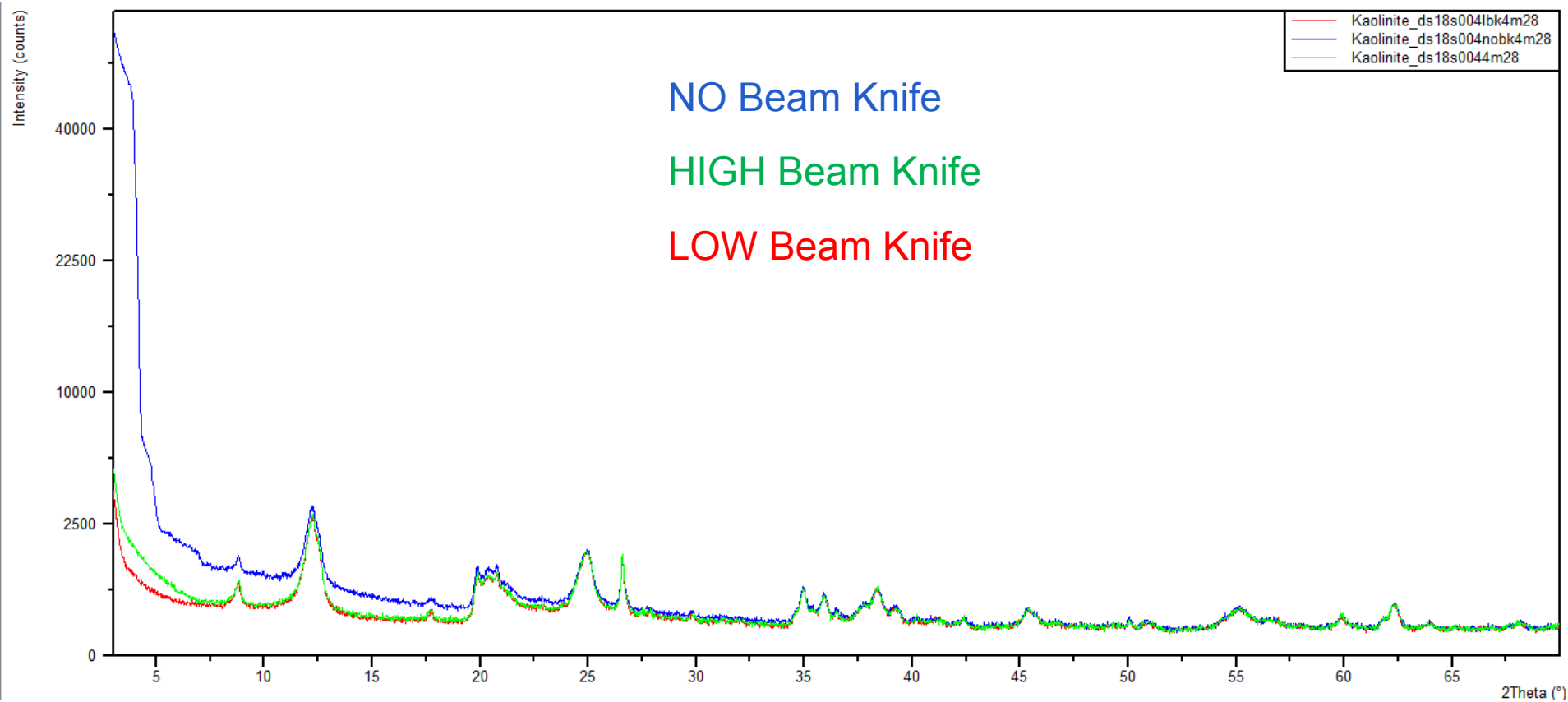
## (2) Use of beam knife

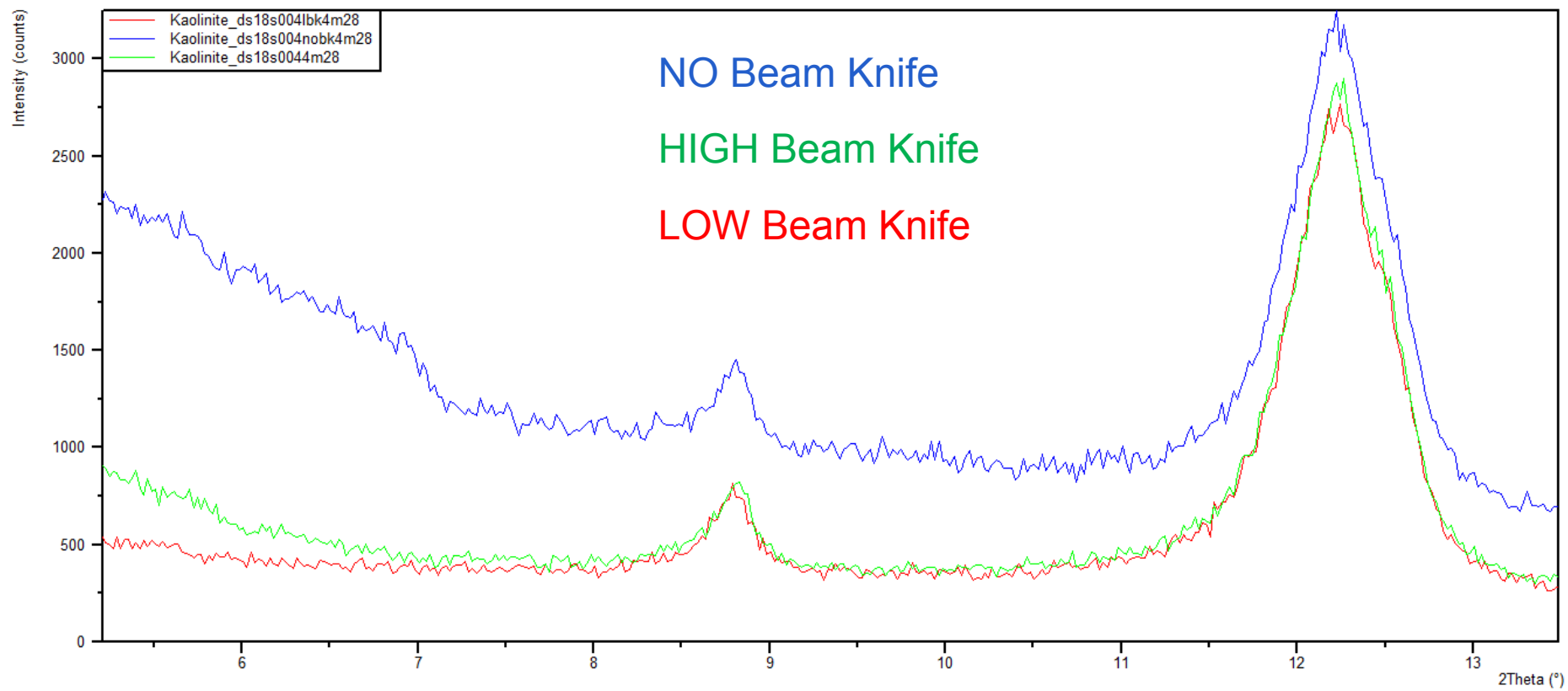
- Fixed divergent slit  $\Rightarrow 1/8^\circ$
- Soller slit  $\Rightarrow 0.04$  rad
- Total time  $\Rightarrow 4'28''$

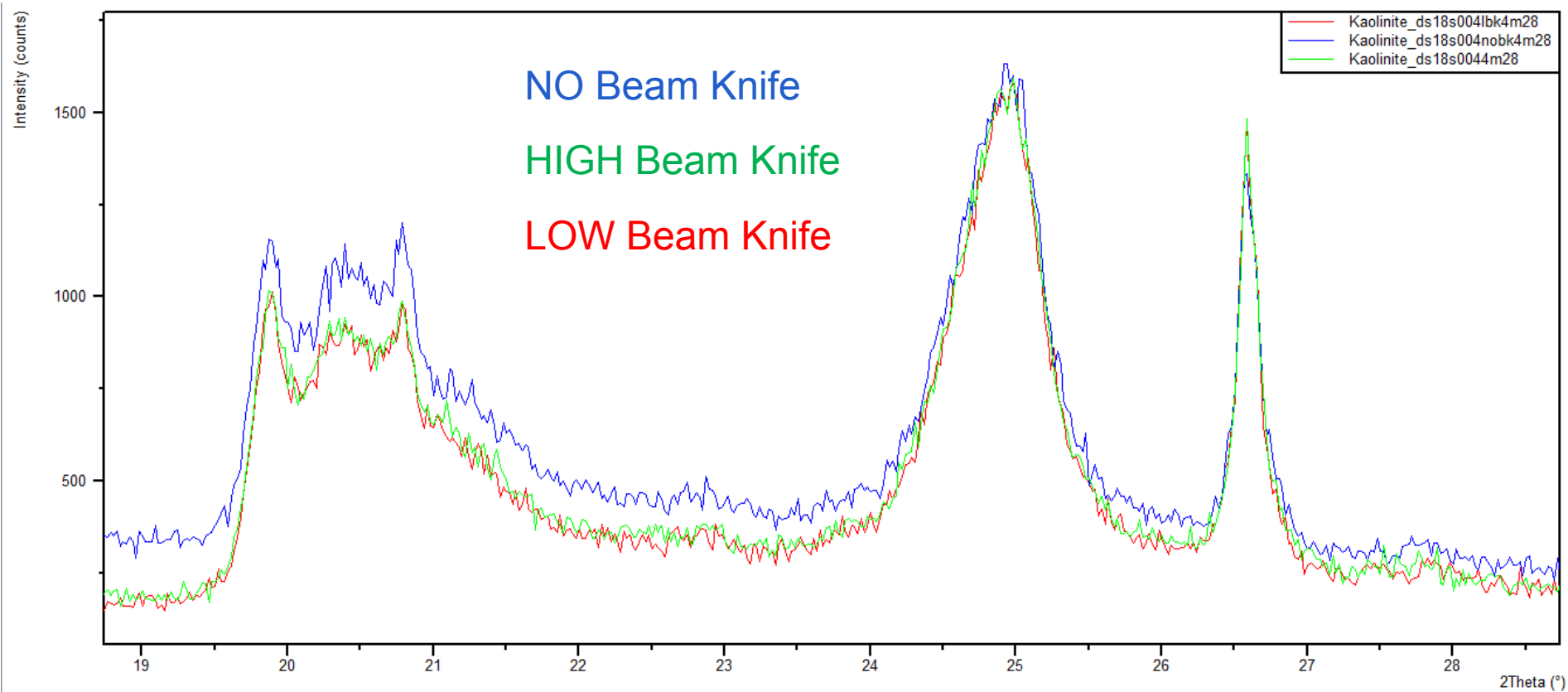
NO Beam Knife

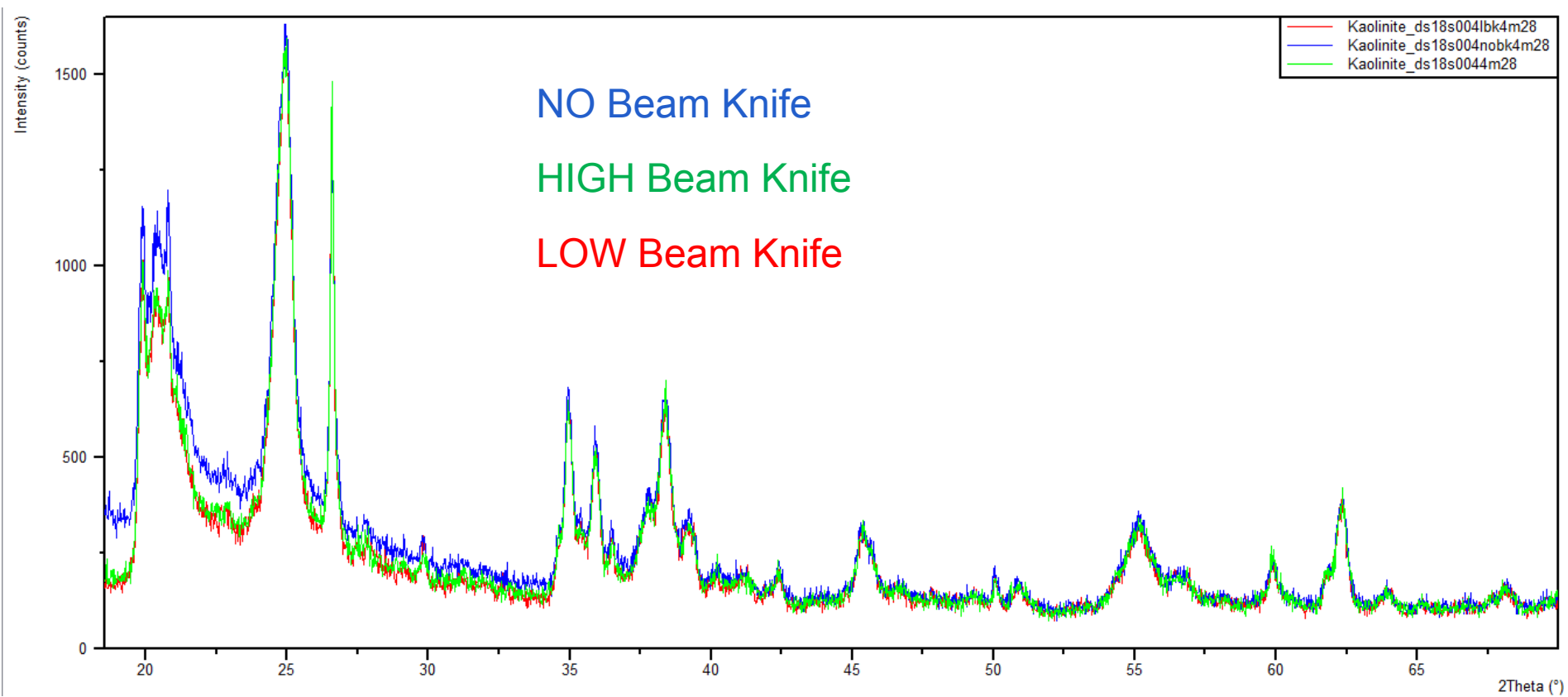
HIGH Beam Knife

LOW Beam Knife











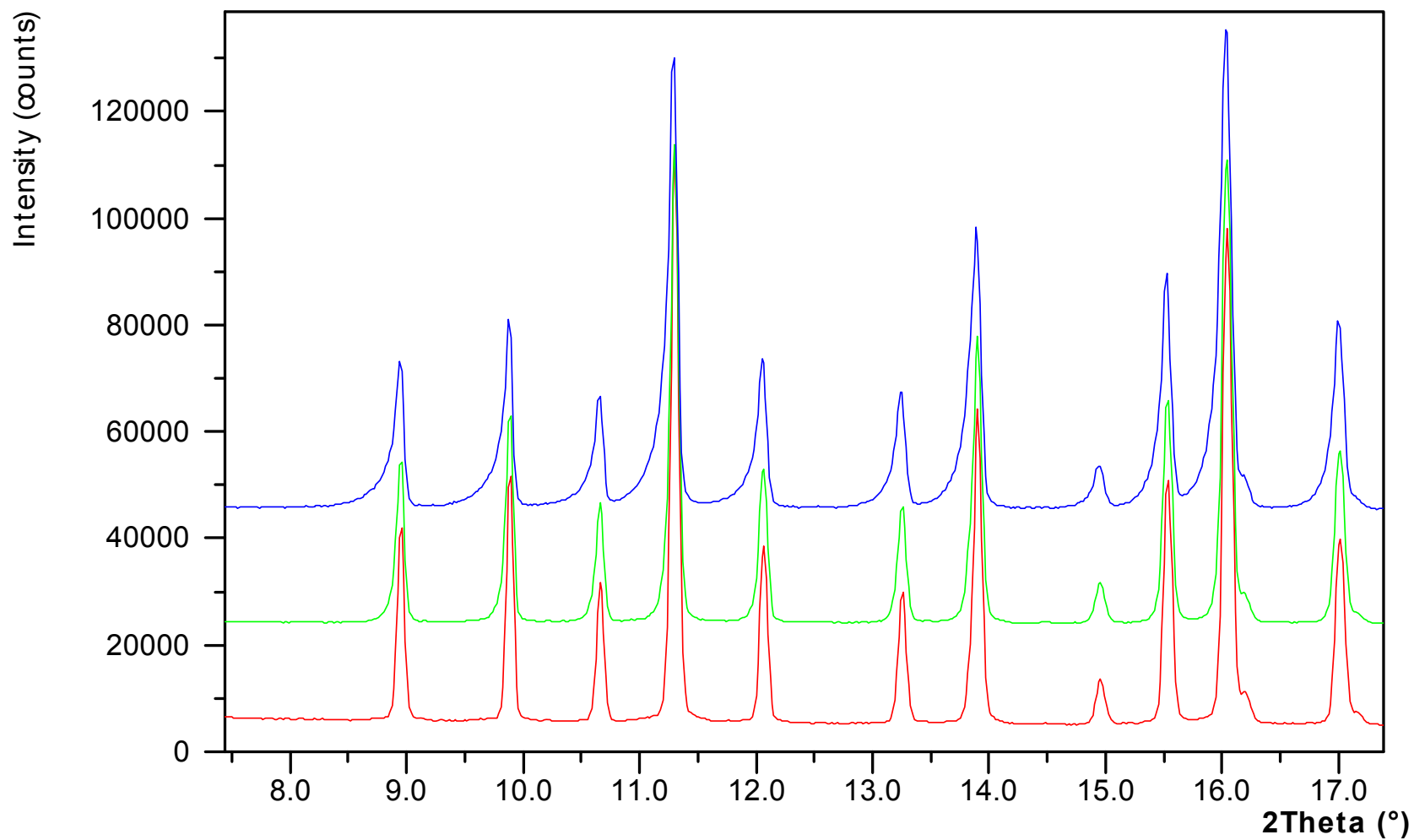
## (3) Soller slits

- 0.04 radians
- 0.02 radians
- 0.01 radians

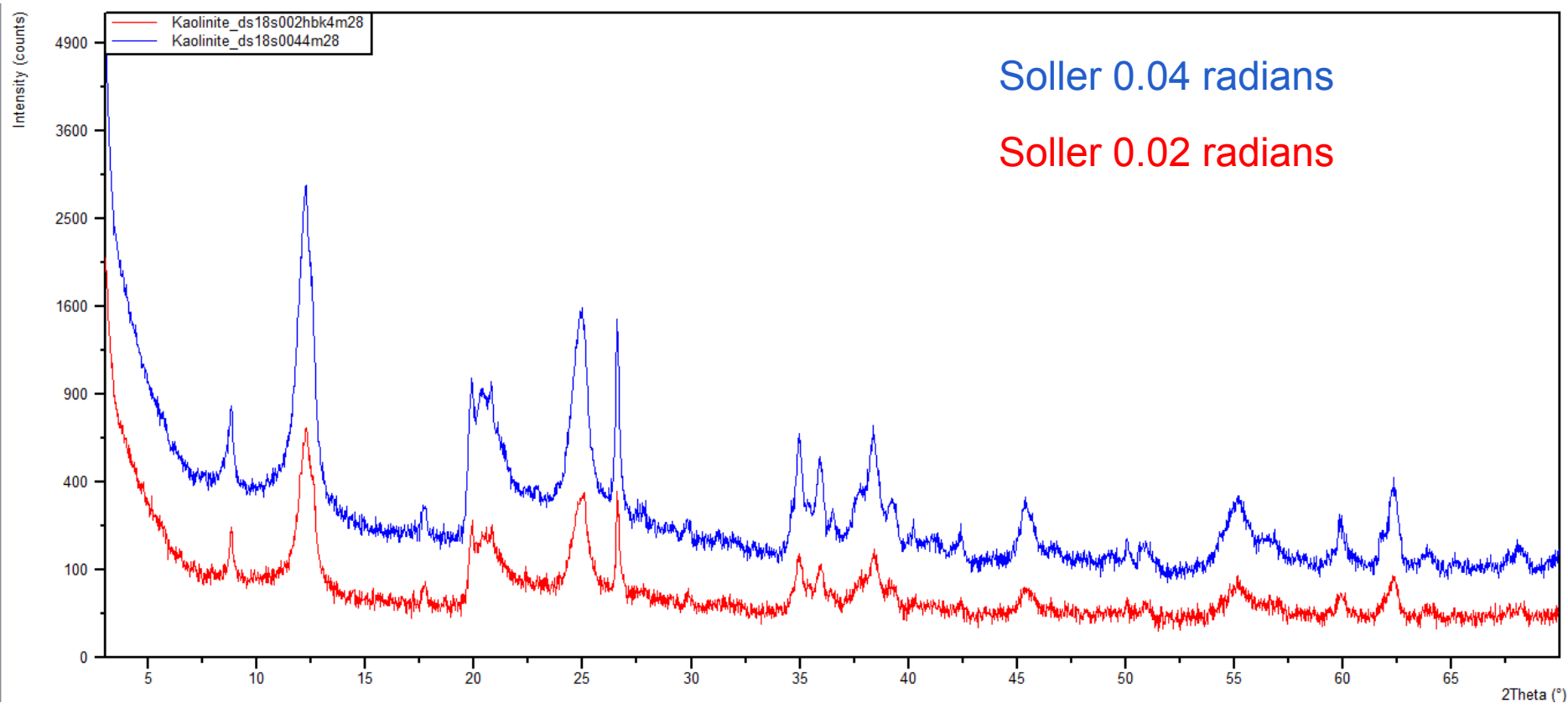


*Relationship between mask's marking and irradiated width in millimeters for the fixed divergence slit*

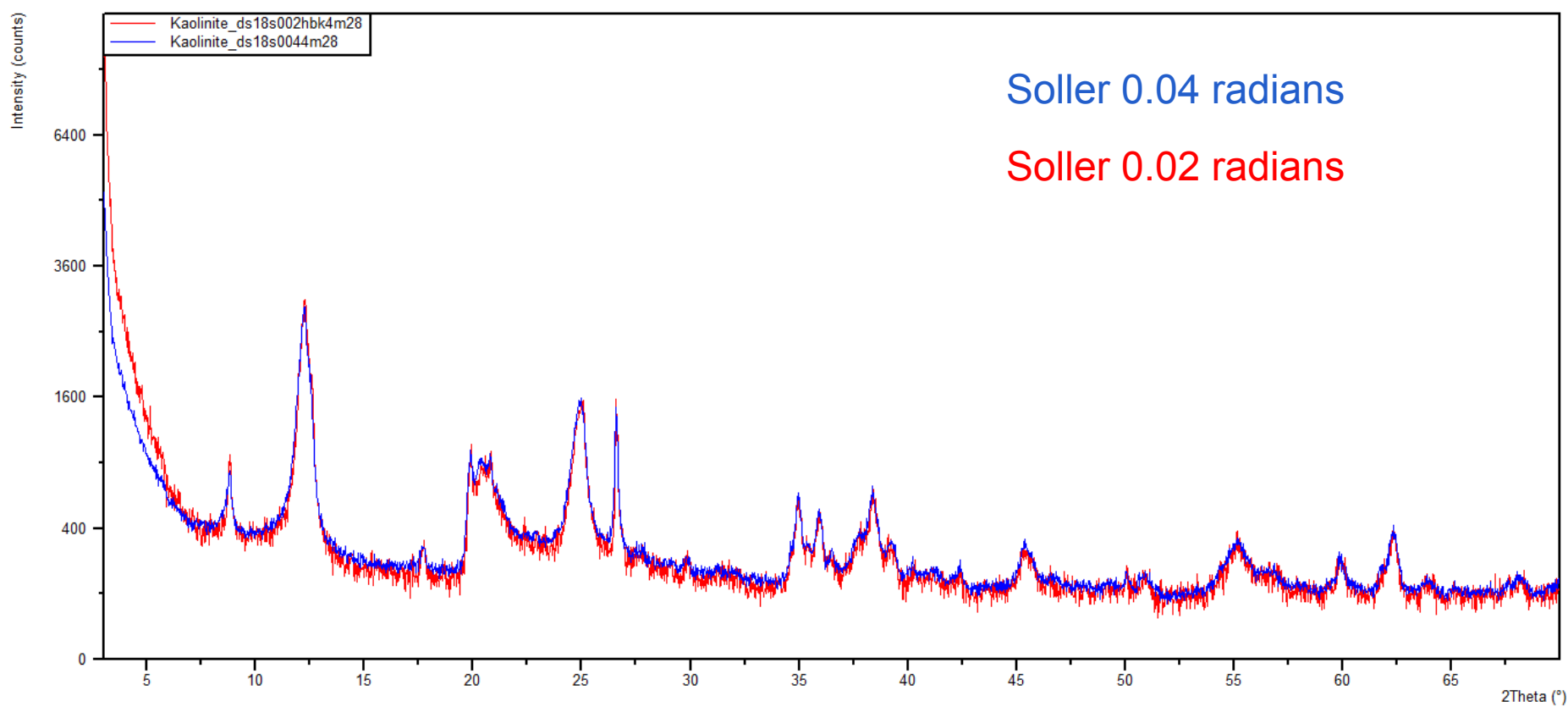
Mask marking	Soller Slits		
	0.01 rad	0.02 rad	0.04 rad
20	18.4	19.9	22.8
15	13.4	14.9	17.8
10	8.4	9.9	12.8
5	3.4	4.9	7.8



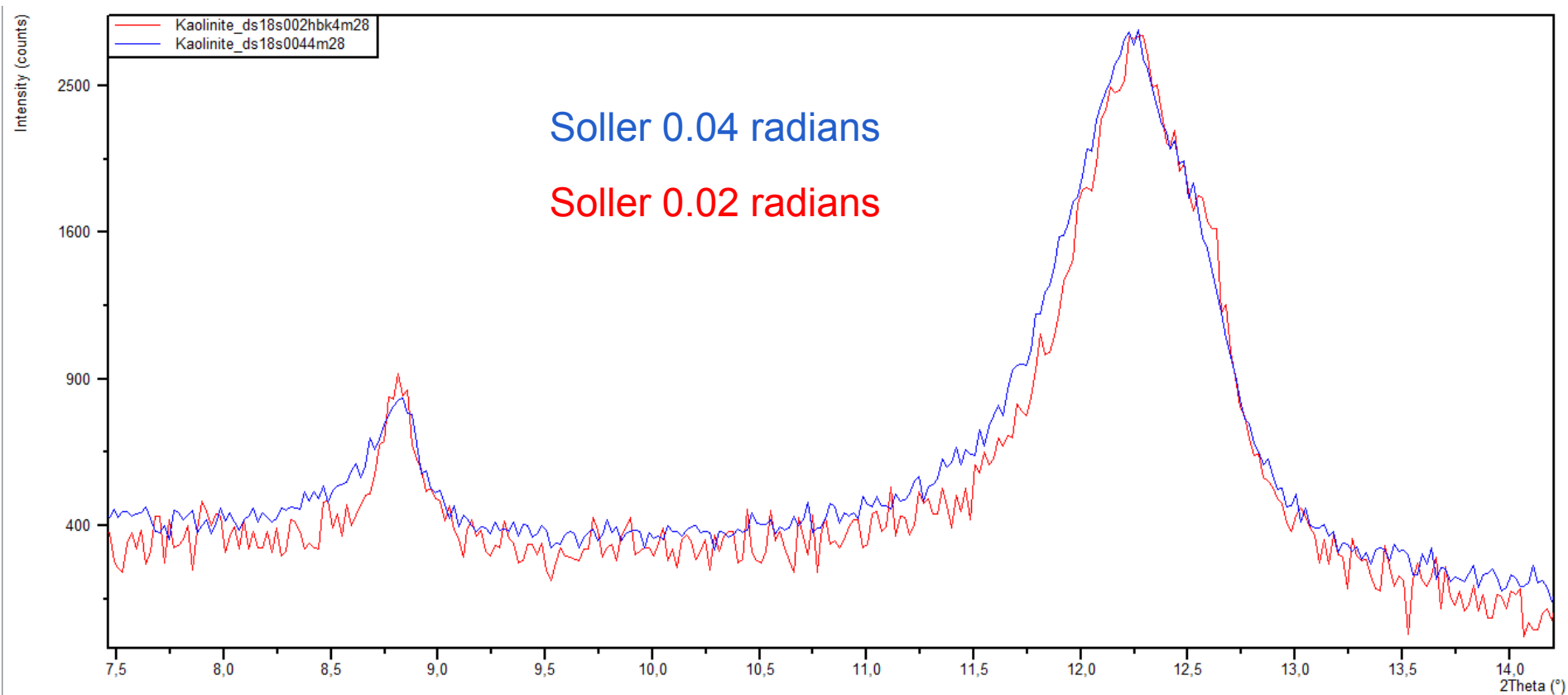
Goniometer radius => 145 mm



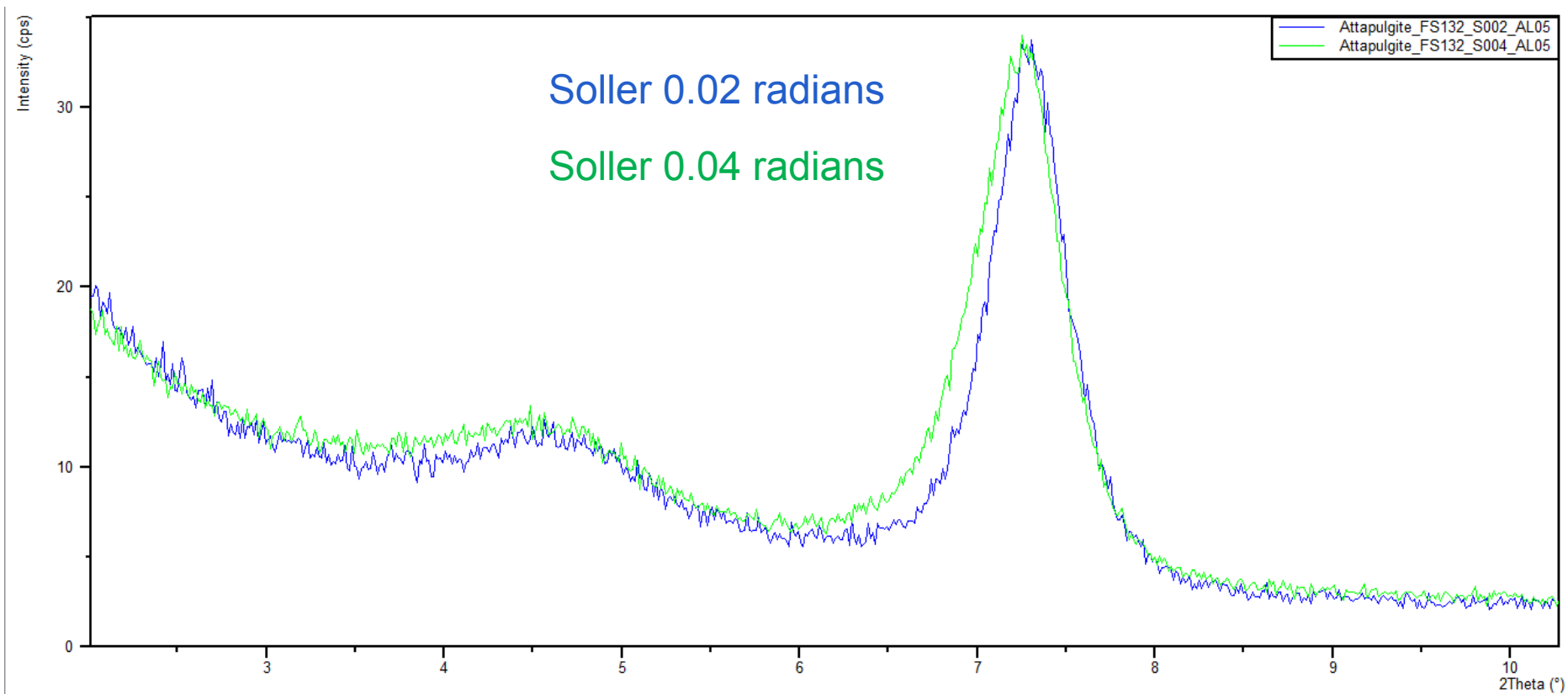
Goniometer radius => 145 mm



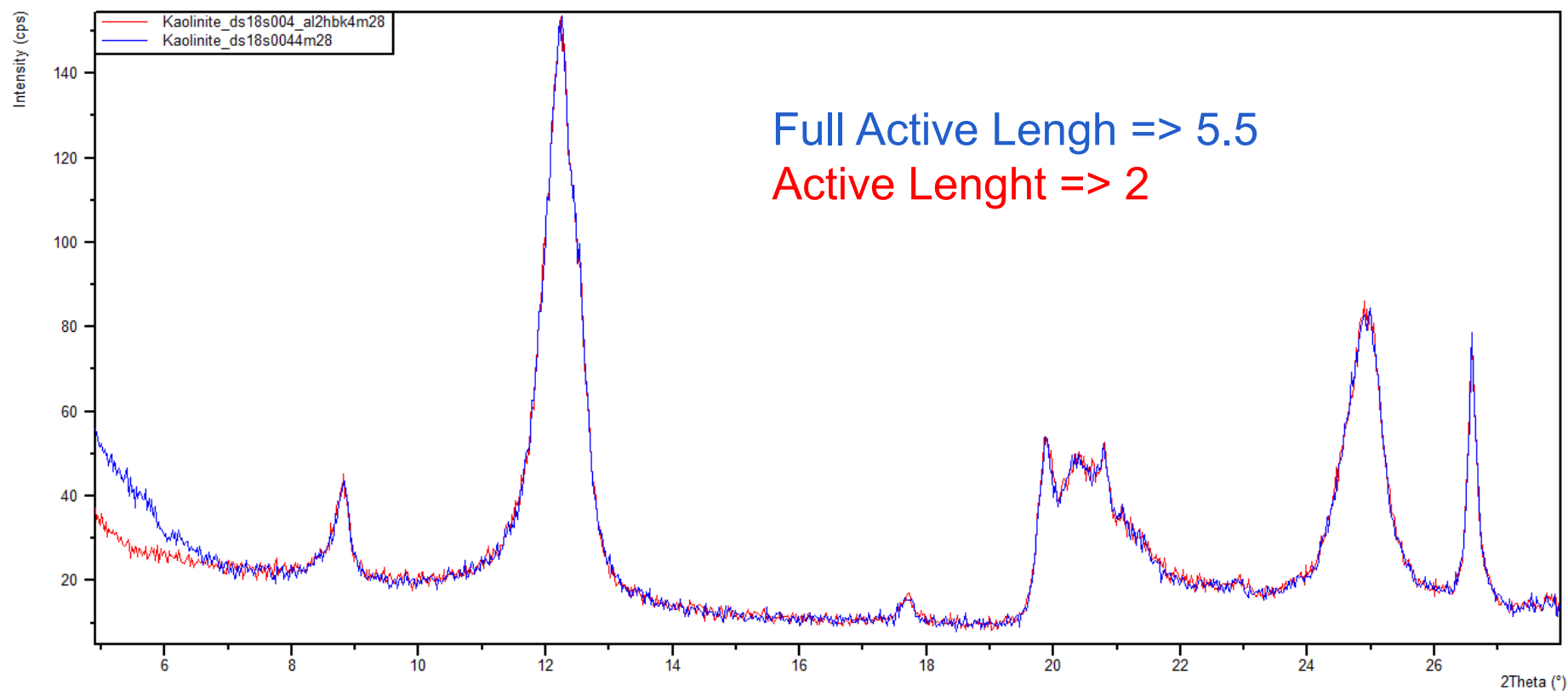
Goniometer radius => 145 mm



Goniometer radius => 240 mm

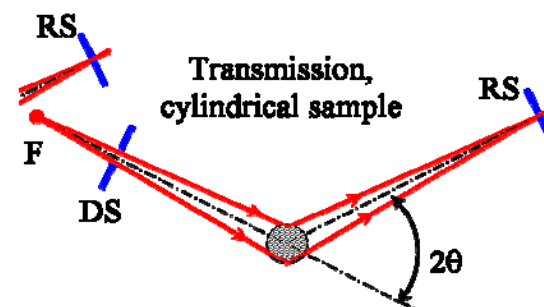
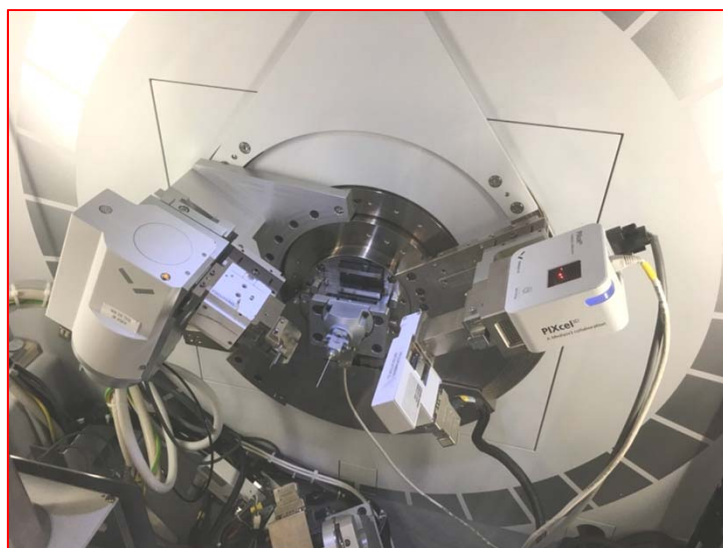


## (4) Active Length



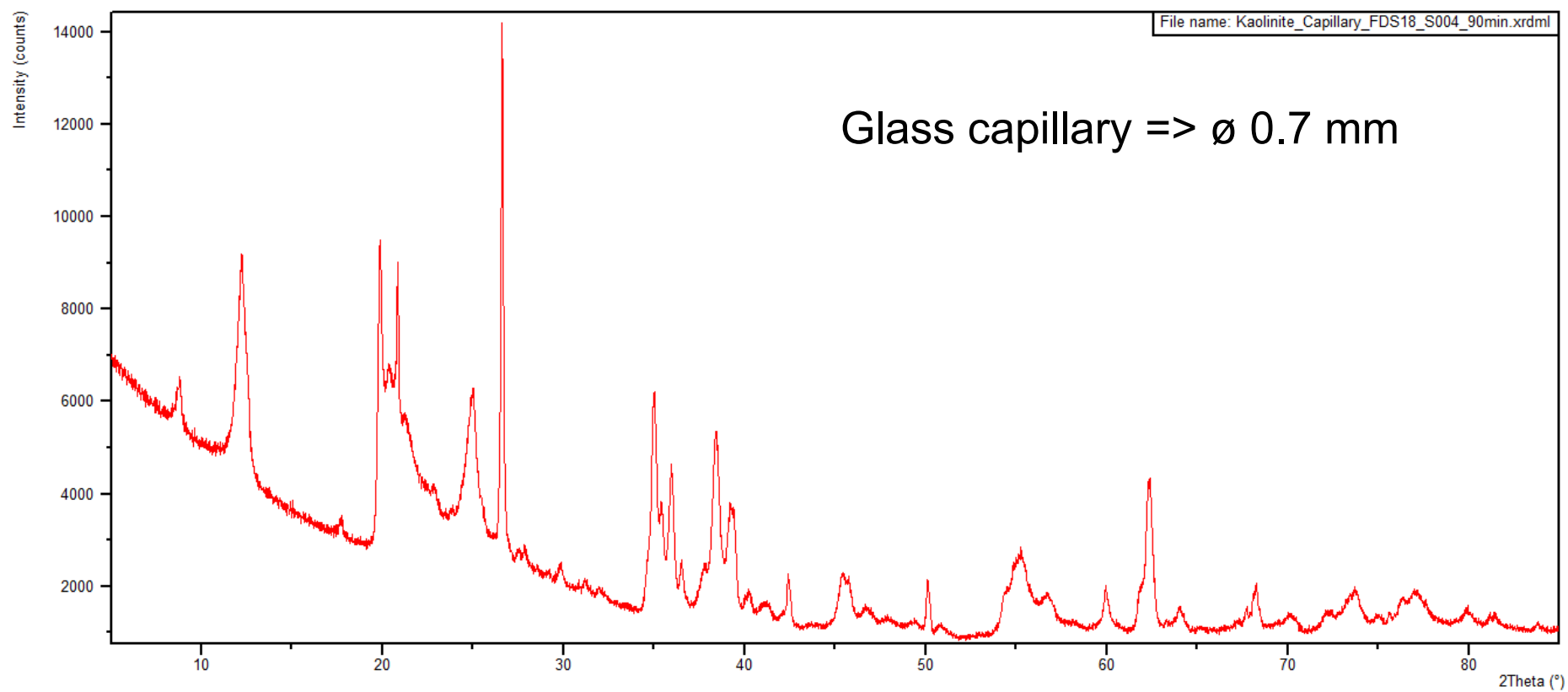
## (5) Cappillary spinner and transmission mode

Glass capillary  $\Rightarrow \varnothing 0.7 \text{ mm}$



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## (6) Goniometer Radius

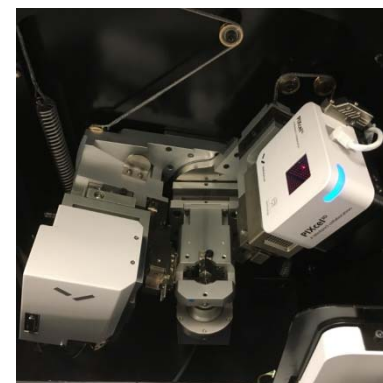
Ø 240 mm

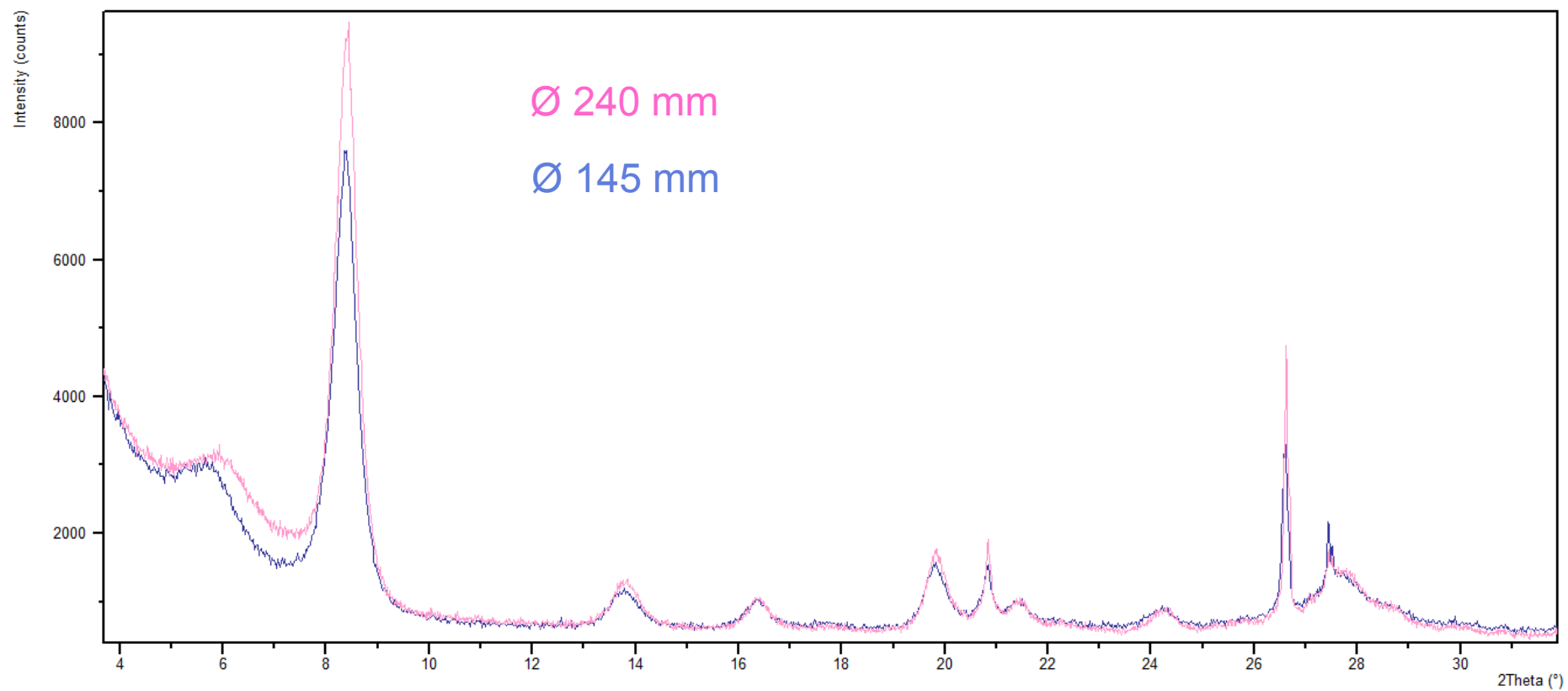


A	Configuration	B
240 mm	<b>Goniometer radius</b>	145 mm
Empyrean	<b>Tube</b>	Empyrean
1/32°	<b>Fixed divergent slit</b>	1/32°
0.02 rad	<b>Soller slit</b>	0.02 rad
Pixcel 3D	<b>Detector</b>	Pixcel 3D
3.3°	<b>Active Length</b>	5.5°
1800 W	<b>Power</b>	600 W

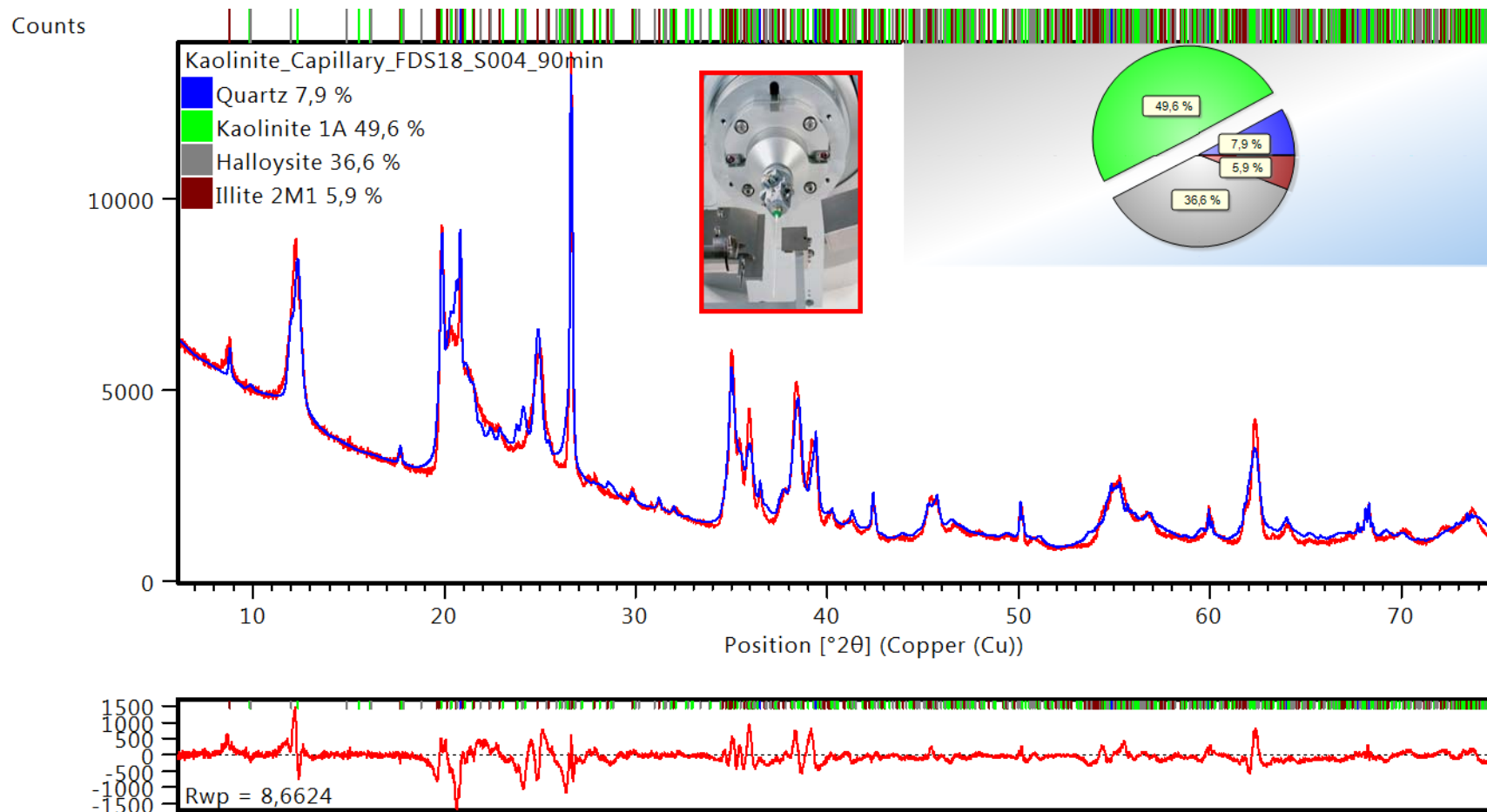


Ø 145 mm

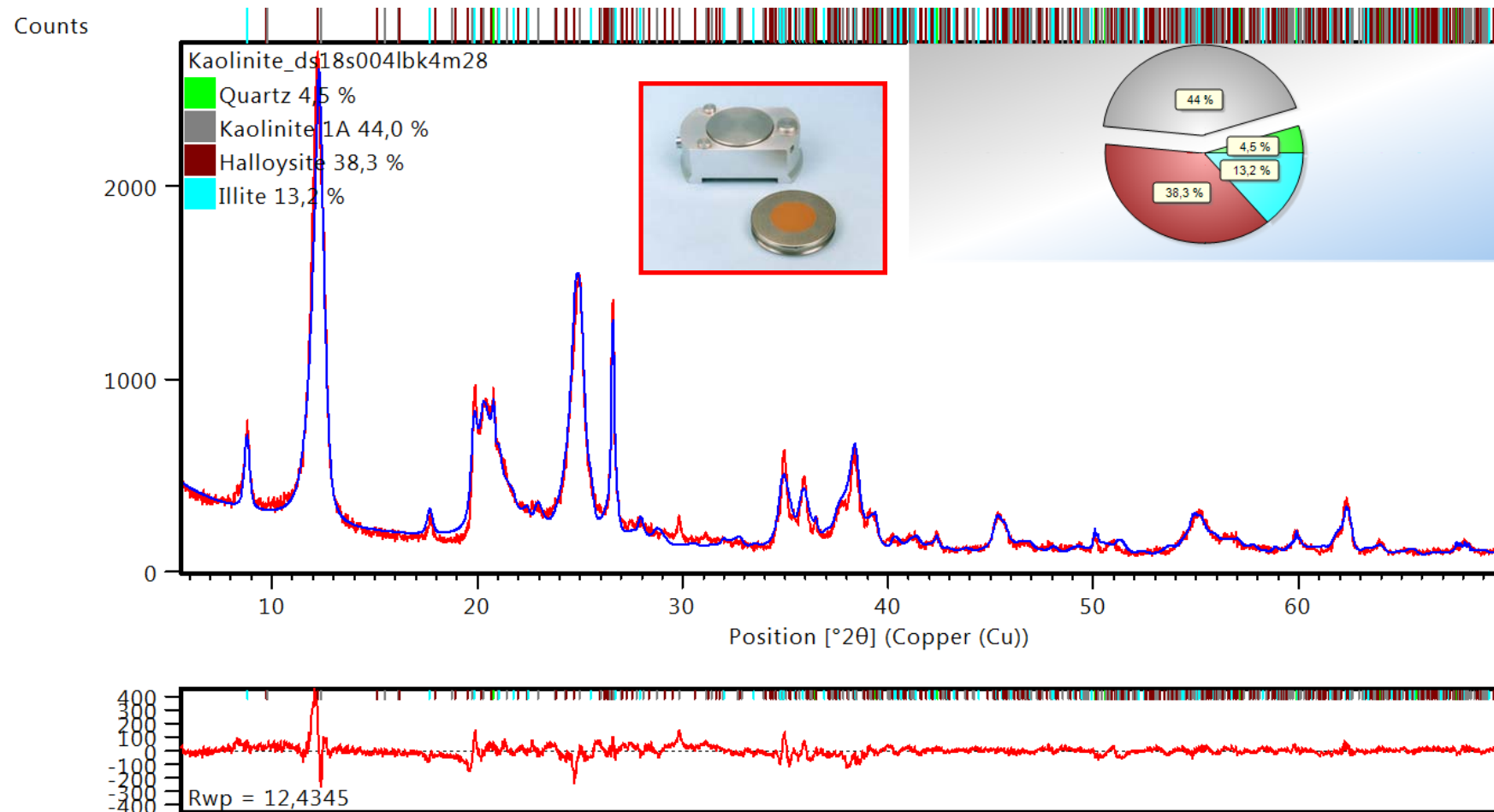




## Capillary Sample



## Pressed powder – backload sample preparation



# Considerations

- It is very important to choose the proper system configuration on clay analysis – (1) peaks at low angles and (2) good resolution
- Quartz main peak can be helpful on verifying the appropriate sample height
- It is important to have between 5-11 points in a peak measured over the FWHM – resolution and low background noise
- Small divergent slits will improve the peak resolution but can decrease the intensities – always play with slit size and time/step
- In samples with multiple phases and with peak overlaps, the use of reduced Soller slits can be very helpful, specially at low angles – and also gives symmetry to the peaks
- The use of beam knife can eliminate the direct beam effect at low angles – therefore it is always important to select the proper height of the knife not to cut the intensity of the main peaks
- Short goniometer radius (145 mm) can give high intensity – in this way the low power (600 watts) does not affect the quality)

Thank you!

